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10/763,540 Examiner

Rene Towa

Applicant(s)/Patent under Reexamination

LI ET AL. Art Unit

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SEARCHED				
Class	Subclass	Date	Examiner	
600	309	7/17/2006	RTT	
600	362	7/17/2006	RTT	
600	573	7/17/2006	RTT	
600	575	7/17/2006	RTT	
600	584	7/17/2006	RTT	
424	439	7/17/2006	RTT	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			 	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
SEE SEARCH HISTORY	7/17/2006	RTT